Unit: mm

TOSHIBA Transistor Silicon NPN Epitaxial Type (PCT process)

# 2SC2716

High Frequency Amplifier Applications
AM High Frequency Amplifier Applications
AM Frequency Converter Applications

• Low noise figure: NF = 3.5dB (max) (f = 1 MHz)

### **Absolute Maximum Ratings (Ta = 25°C)**

Characteristics	Symbol	Rating	Unit
Collector-base voltage	V <sub>CBO</sub>	35	V
Collector-emitter voltage	V <sub>CEO</sub>	30	V
Emitter-base voltage	V <sub>EBO</sub>	4	V
Collector current	Ic	100	mA
Emitter current	ΙE	-100	mA
Collector power dissipation	PC	150	wW
Junction temperature	Tj	125	°C
Storage temperature range	T <sub>stg</sub>	-55~125	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e.

Weight: 0.012 g (typ.)

operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Electrical Characteristics (Ta = 25°C)**

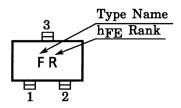
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I <sub>CBO</sub>	$V_{CB} = 20 \text{ V}, I_{E} = 0$	_	_	0.1	μА
Emitter cut-off current	I <sub>EBO</sub>	V <sub>EB</sub> = 2 V, I <sub>C</sub> = 0	_	_	1.0	μА
DC current gain	h <sub>FE</sub> (Note)	V <sub>CE</sub> = 12 V, I <sub>C</sub> = 2 mA		_	240	
Collector-emitter saturation voltage	V <sub>CE</sub> (sat)	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$	_	_	0.4	V
Base-emitter saturation voltage	V <sub>BE (sat)</sub>	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$	_	_	1.0	V
Transition frequency	f <sub>T</sub>	V <sub>CE</sub> = 10 V, I <sub>C</sub> = 2 mA	80	120	_	MHz
Reverse transfer capacitance	C <sub>re</sub>	V <sub>CB</sub> = 10 V, I <sub>E</sub> = 0, f = 1 MHz	_	2.2	3.0	pF
Collector-base time constant	C <sub>c</sub> .rbb'	$V_{CE} = 10 \text{ V}, I_{E} = -1 \text{ mA}, f = 30 \text{ MHz}$	_	30	50	ps
Noise figure	NF	$V_{CE}$ = 10 V, $I_{E}$ = -1 mA, $f$ = 1 MHz $R_{g}$ = 50 $\Omega$	_	2.0	3.5	dB

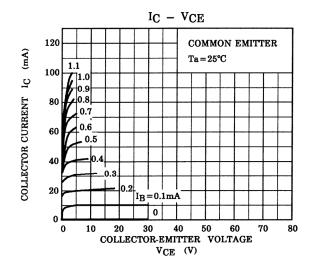
Note: hFE classification R: 40~80, O: 70~140, Y: 120~240

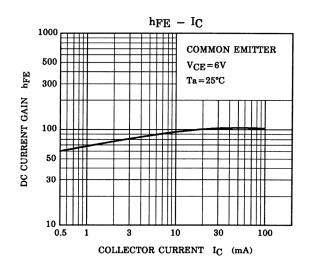
## y Parameter (typ.) (common emitter VCE = 6 V, IE = -1 mA, f = 1 MHz)

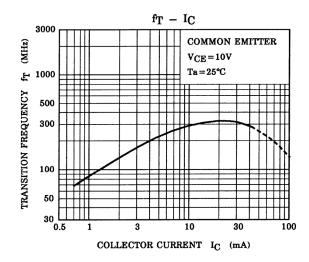
Characteristics	Symbol	2SC2716-R	2SC2716-O	2SC2716-Y	Unit
Input conductance	9ie	0.5	0.35	0.22	mS
Input capacitance	C <sub>ie</sub>	50	48	46	pF
Output conductance	9oe	4	5	6.5	μS
Output capacitance	C <sub>oe</sub>	3.7	3.4	3.2	pF
Forward transfer admittance	y <sub>fe</sub>	36	36	36	mS
Phase angle of forward transfer admittance	θ <sub>fe</sub>	-1.6	-1.6	-1.6	۰
Reverse transfer admittance	y <sub>re</sub>	14	14	14	μS
Phase angle of reverse transfer admittance	$\theta_{\sf re}$	-90	-90	-90	٥

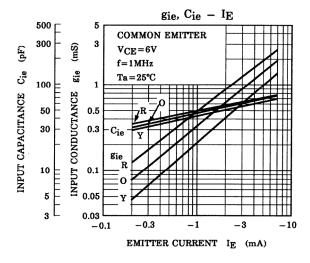
## Marking

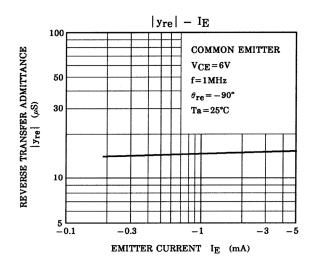


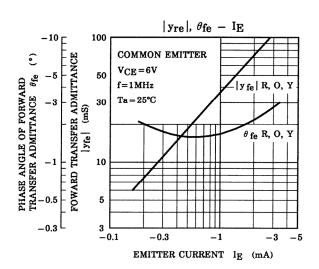




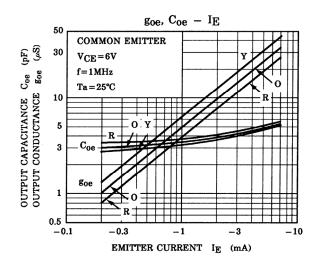


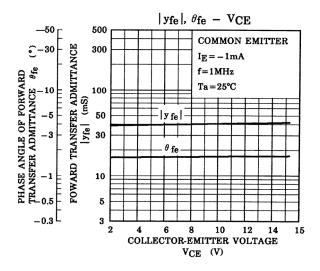


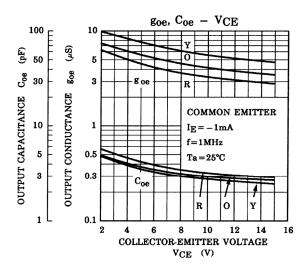


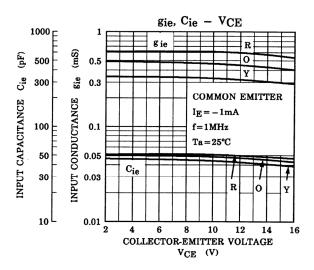


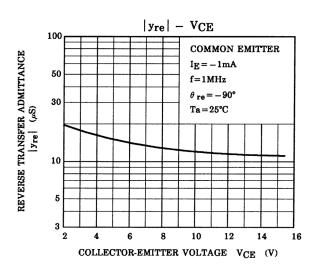
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20070701-EN GENERAL

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